Issue Classification



CLASS

(Primary Examiner)

ORIGINAL

SUBCLASS

Application/Control No.	Applicant(s)/Patent Under Reexamination							
10518087	INOUE, FUJIO							
Examiner	Art Unit							
Chen-Wen Jiang	3744							

CLAIMED

INTERNATIONAL CLASSIFICATION

NON-CLAIMED

236 101C						G	0	5	D	23 / 02 (2006.01	.01)					
CROSS REFERENCE(S)					G	0	5	D	23 / 00 (2006.01	.01)						
						F	0	1	Р	7 / 02 (2006.01	.01)					
CLASS SUBCLASS (ONE SUBCLASS PER BLOCK					CK)											
236	93R	34.5														
NONE											Total Claims Allowed:					
(Assistant Examiner) (Date)											Total Claims Allowed:					
/Chen-Wen Jiang/									7/	/7/08	O.G. Print Claim(s) O.G. Print Figure					

(Date)

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